



Sheet 1 of 1

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. ASA-915	SERIAL NO. 09/645,404
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT A. IMAIZUMI et al	
		FILING DATE 08/25/00	GROUP 2623

## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
jc	AL 0 809 219	11/26/97	EP	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
jc	AM 0 616 296	09/21/94	EP	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

jc	AR	P. Herrmann et al, "Retrieval of Document Images Using Layout Knowledge", IEEE Comp. Soc., 1993, pp. 537-540.
jc	AS	M. Junker et al, "Evaluating OCR and Non-OCR Text Representations for Learning Document Classifiers", IEEE Comp. Soc., Vol. II, 1997, pp. 1060- 1066.
jc	AT	Tun-Wen Pai et al, "An Intelligent Chinese Official Document Processing System", IEEE Comp. Soc., 1995, pp. 974-977.

EXAMINER <i>Jim Chang</i>	DATE CONSIDERED 5/1/05
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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## FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
Jc	AL 7-273922	10/20/95	JP (with English Abstract)	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Jc	AM 9-330363	12/22/97	JP (with English Abstract)	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	
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